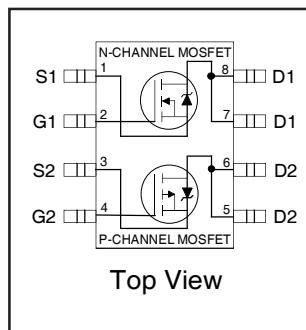


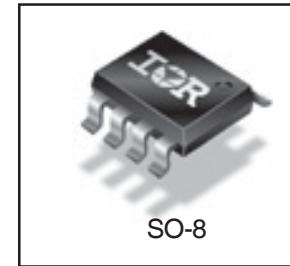
### Features

- Advanced Planar Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- Dual N and P Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- 150°C Operating Temperature
- Automotive [Q101] Qualified\*
- Lead-Free, RoHS Compliant



HEXFET® Power MOSFET

	N-Ch	P-Ch
$V_{(BR)DSS}$	55V	-55V
$R_{DS(on)}$	typ.	0.043Ω
	max.	0.050Ω
$I_D$	4.7A	-3.4A



G	D	S
Gate	Drain	Source

### Description

Specifically designed for Automotive applications, these HEXFET® Power MOSFET's in a Dual SO-8 package utilize the lastest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of these Automotive qualified HEXFET Power MOSFET's are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These benefits combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

The efficient SO-8 package provides enhanced thermal characteristics and dual MOSFET die capability making it ideal in a variety of power applications. This dual, surface mount SO-8 can dramatically reduce board space and is also available in Tape & Reel.

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF7343Q	SO-8	Tube	95	AUIRF7343Q
		Tape and Reel	4000	AUIRF7343QTR

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

	Parameter	Max.		Units
		N-Channel	P-Channel	
$V_{DS}$	Drain-Source Voltage	55	-55	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	4.7	-3.4	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	3.8	-2.7	
$I_{DM}$	Pulsed Drain Current ①	38	-27	
$P_D @ T_A = 25^\circ C$	Power Dissipation ⑤	2.0		W
$P_D @ T_A = 70^\circ C$	Power Dissipation ⑤	1.3		
$E_{AS}$	Single Pulse Avalanche Energy ③	72	114	mJ
$I_{AR}$	Avalanche Current	4.7	-3.4	A
$E_{AR}$	Repetitive Avalanche Energy	0.20		mJ
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$		V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	5.0	-5.0	V/ns
$T_J$	Operating Junction and	-55 to + 150		°C
$T_{STG}$	Storage Temperature Range			

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{θJA}$	Junction-to-Ambient ⑥	—	62.5	°C/W

HEXFET® is a registered trademark of International Rectifier.

\*Qualification standards can be found at <http://www.irf.com/>

### Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)

	Parameter		Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	N-Ch	55	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
		P-Ch	-55	—	—		$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.059	—	$^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
		P-Ch	—	0.054	—		Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	N-Ch	—	0.043	0.050	$\Omega$	$V_{GS} = 10\text{V}, I_D = 4.7\text{A}$ ④
			—	0.056	0.065		$V_{GS} = 4.5\text{V}, I_D = 3.8\text{A}$ ④
		P-Ch	—	0.095	0.105		$V_{GS} = -10\text{V}, I_D = -3.4\text{A}$ ④
			—	0.150	0.170		$V_{GS} = -4.5\text{V}, I_D = -2.7\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	N-Ch	1.0	—	—	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
		P-Ch	-1.0	—	—		$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_{fs}$	Forward Transconductance	N-Ch	7.9	—	—	S	$V_{DS} = 10\text{V}, I_D = 4.5\text{A}$ ④
		P-Ch	3.3	—	—		$V_{DS} = -10\text{V}, I_D = -3.1\text{A}$ ④
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	N-Ch	—	—	2.0	$\mu\text{A}$	$V_{DS} = 55\text{V}, V_{GS} = 0\text{V}$
		P-Ch	—	—	-2.0		$V_{DS} = -55\text{V}, V_{GS} = 0\text{V}$
		N-Ch	—	—	25		$V_{DS} = 55\text{V}, V_{GS} = 0\text{V}, T_J = 55^\circ\text{C}$
		P-Ch	—	—	-25		$V_{DS} = -55\text{V}, V_{GS} = 0\text{V}, T_J = 55^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	—	$\pm 100$	nA	$V_{GS} = \pm 20\text{V}$

### Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)

	Parameter		Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge	N-Ch	—	24	36	nC	N-Channel
		P-Ch	—	26	38		$I_D = 4.5\text{A} V_{DS} = 44\text{V}, V_{GS} = 10\text{V}$
$Q_{gs}$	Gate-to-Source Charge	N-Ch	—	2.3	3.4		P-Channel
		P-Ch	—	3.0	4.5		$I_D = -3.1\text{A} V_{DS} = -44\text{V}, V_{GS} = -10\text{V}$ ④
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	N-Ch	—	7.0	10		
		P-Ch	—	8.4	13		
$t_{d(on)}$	Turn-On Delay Time	N-Ch	—	8.3	12	ns	N-Channel
		P-Ch	—	14	22		$V_{DD} = 28\text{V}, ID=1.0\text{A}, RG = 6.0\Omega$
$t_r$	Rise Time	N-Ch	—	3.2	4.8		$R_D = 28\Omega$
		P-Ch	—	10	15		P-Channel
$t_{d(off)}$	Turn-Off Delay Time	N-Ch	—	32	48		$V_{DD} = -28\text{V}, ID=-1.0\text{A}, RG = 6.0\Omega$
		P-Ch	—	43	64		$R_D = 28\Omega$
$t_f$	Fall Time	N-Ch	—	13	20		
		P-Ch	—	22	32		
$C_{iss}$	Input Capacitance	N-Ch	—	740	—	pF	N-Channel
		P-Ch	—	690	—		$VGS = 0\text{V}, V_{DS} = 25\text{V}, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	N-Ch	—	190	—		P-Channel
		P-Ch	—	210	—		$VGS = 0\text{V}, V_{DS} = -25\text{V}, f = 1.0\text{MHz}$
$C_{rss}$	Reverse Transfer Capacitance	N-Ch	—	71	—		
		P-Ch	—	86	—		

### Diode Characteristics

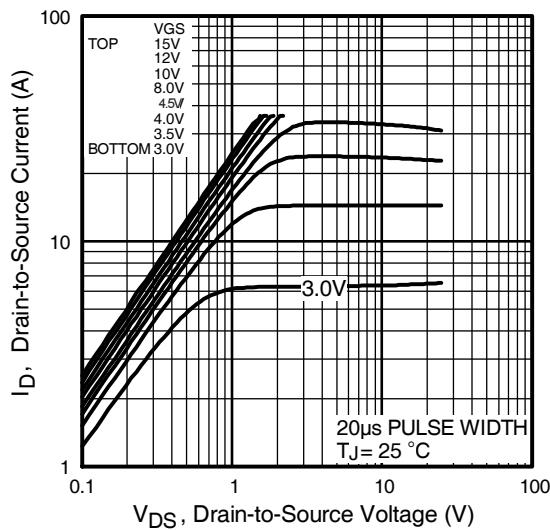
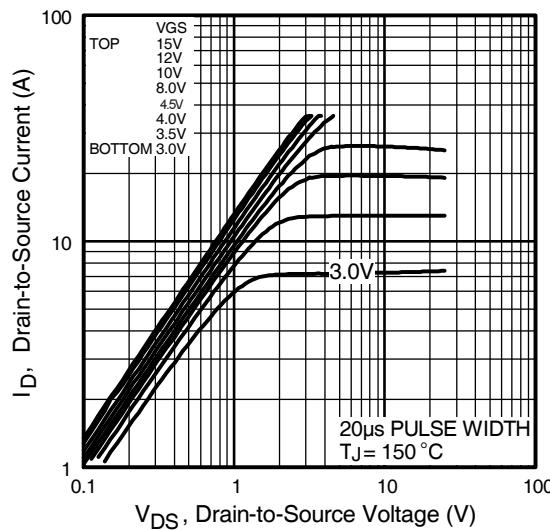
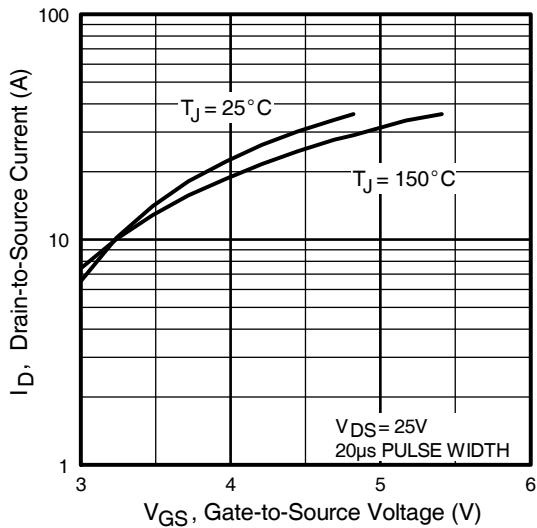
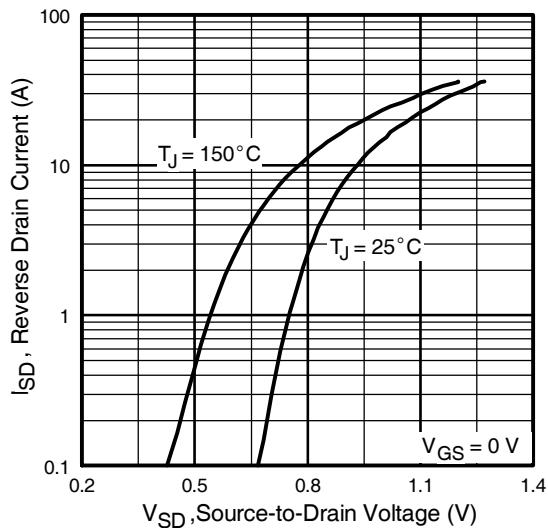
	Parameter		Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	N-Ch	—	—	2.0	A	
		P-Ch	—	—	-2.0		
$I_{SM}$	Pulsed Source Current (Body Diode) ①	N-Ch	—	—	38		
		P-Ch	—	—	-27		
$V_{SD}$	Diode Forward Voltage	N-Ch	—	0.70	1.2	V	$T_J = 25^\circ\text{C}, I_S = 2.0\text{A}, V_{GS} = 0\text{V}$ ③
		P-Ch	—	-0.80	-1.2		$T_J = 25^\circ\text{C}, I_S = -2.0\text{A}, V_{GS} = 0\text{V}$ ③
$t_{rr}$	Reverse Recovery Time	N-Ch	—	60	90	ns	N-Channel
		P-Ch	—	54	80		$T_J = 25^\circ\text{C}, I_F = 2.0\text{A} di/dt = 100\text{A}/\mu\text{s} f$
$Q_{rr}$	Reverse Recovery Charge	N-Ch	—	120	170	nC	P-Channel
		P-Ch	—	85	130		$T_J = 25^\circ\text{C}, I_F = -2.0\text{A} di/dt = 100\text{A}/\mu\text{s} f$ ④

#### Notes:

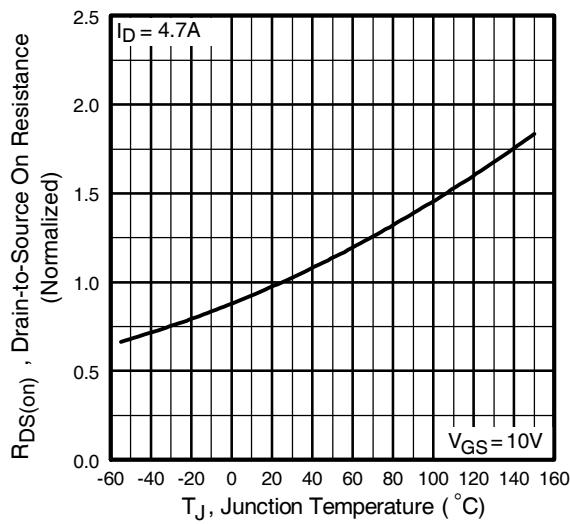
- ① Repetitive rating; pulse width limited by max. junction temperature.  
(See fig. 22)  
② N-Channel  $I_{SD} \leq 4.7\text{A}$ ,  $di/dt \leq 220\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$   
P-Channel  $I_{SD} \leq -3.4\text{A}$ ,  $di/dt \leq -150\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$

- ③ N-Channel Starting  $T_J = 25^\circ\text{C}$ ,  $L = 6.5\text{mH}$   $R_G = 25\Omega$ ,  $I_{AS} = 4.7\text{A}$ .  
P-Channel Starting  $T_J = 25^\circ\text{C}$ ,  $L = 20\text{mH}$   $R_G = 25\Omega$ ,  $I_{AS} = -3.4\text{A}$ .  
④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .  
⑤ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

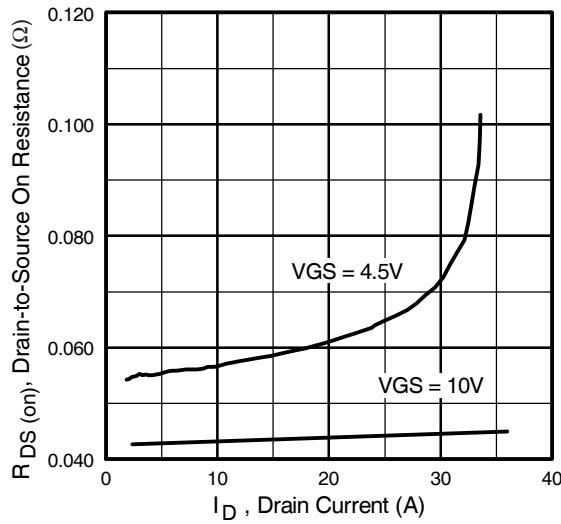
## N-Channel

**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Typical Source-Drain Diode Forward Voltage

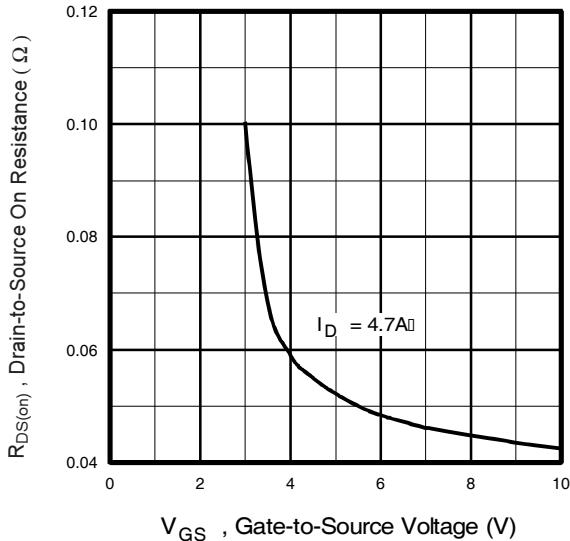
## N-Channel



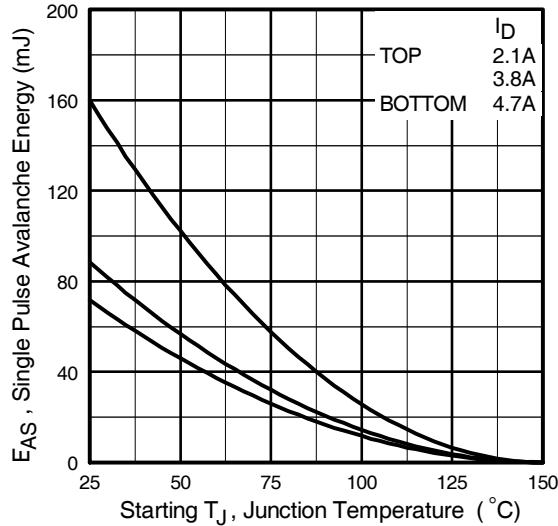
**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current

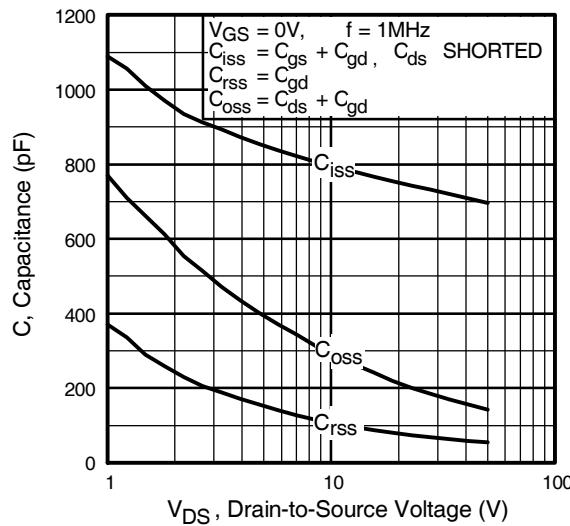


**Fig 7.** Typical On-Resistance Vs. Gate Voltage

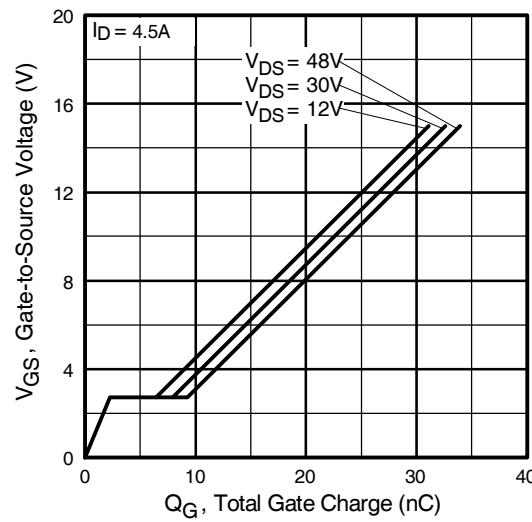


**Fig 8.** Maximum Avalanche Energy Vs. Drain Current

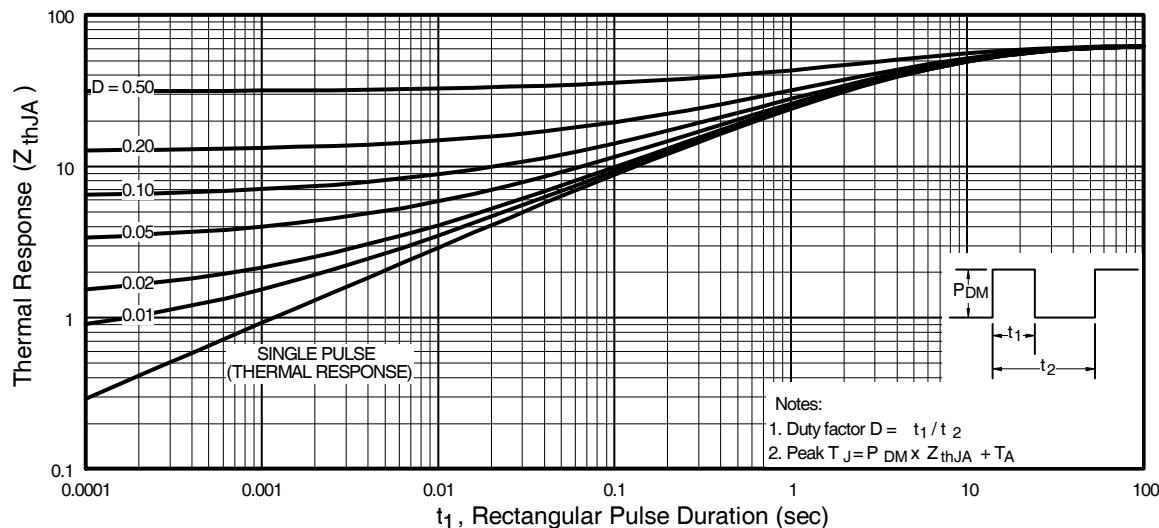
## N-Channel



**Fig 9.** Typical Capacitance Vs.  
Drain-to-Source Voltage



**Fig 10.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

## P-Channel

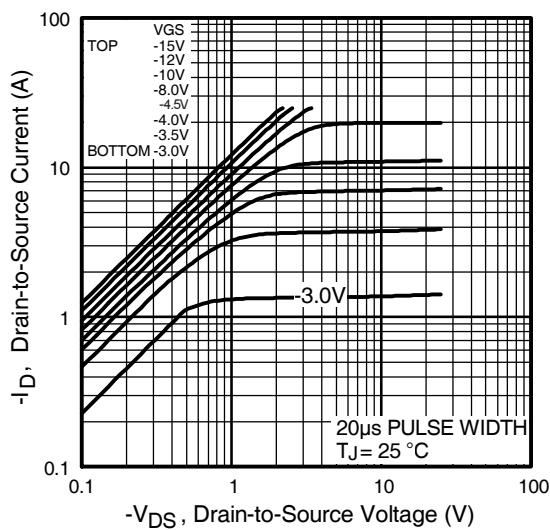


Fig 12. Typical Output Characteristics

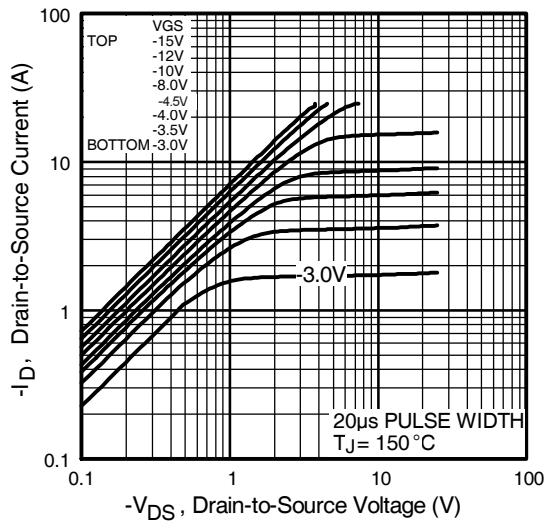


Fig 13. Typical Output Characteristics

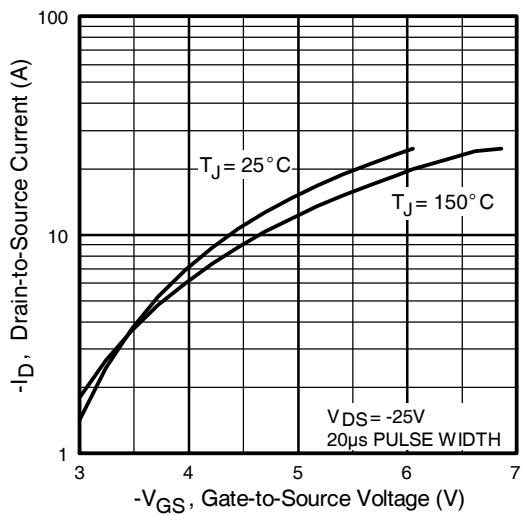


Fig 14. Typical Transfer Characteristics

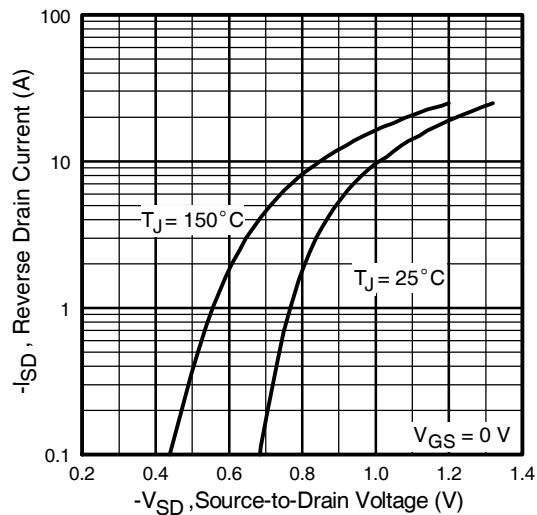
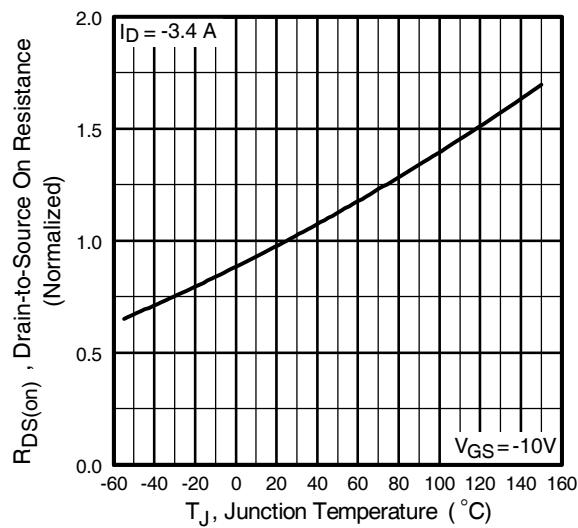
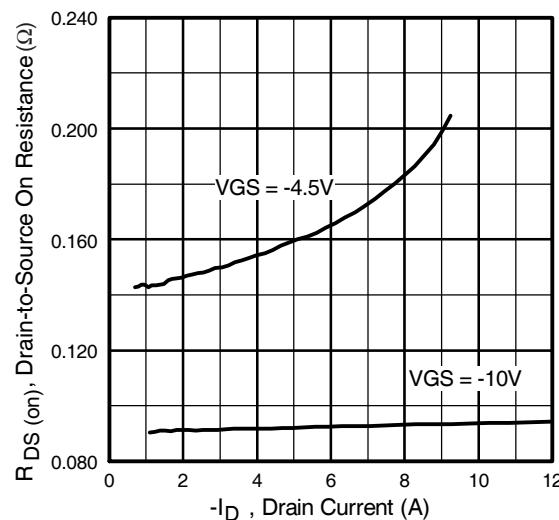


Fig 15. Typical Source-Drain Diode Forward Voltage

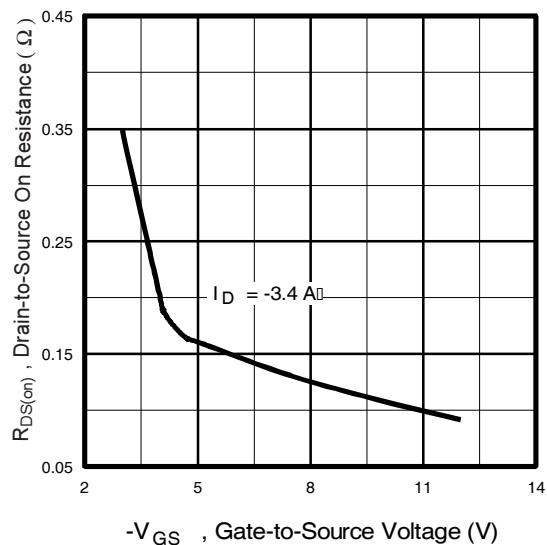
## P-Channel



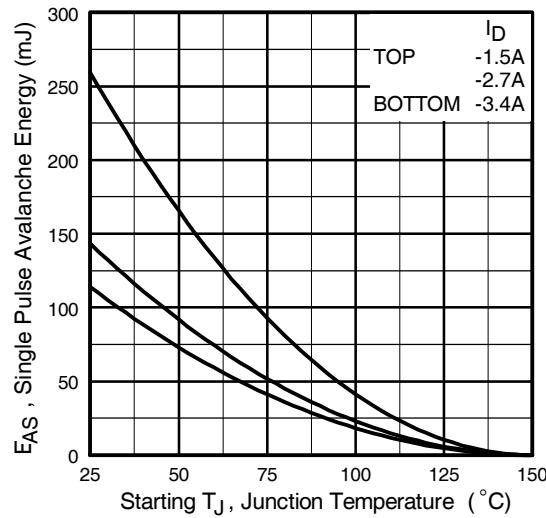
**Fig 16.** Normalized On-Resistance Vs. Temperature



**Fig 17.** Typical On-Resistance Vs. Drain Current

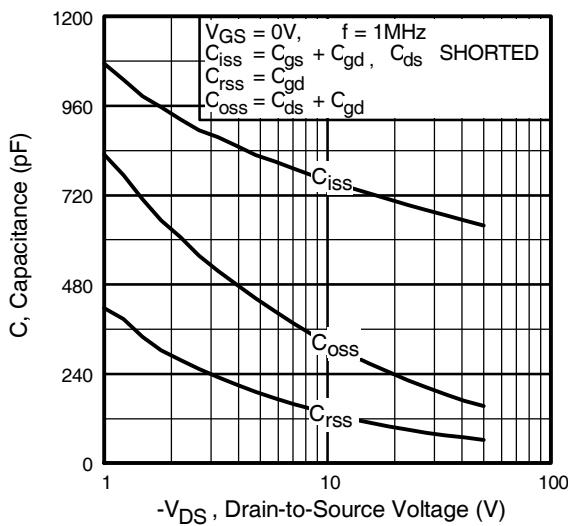


**Fig 18.** Typical On-Resistance Vs. Gate Voltage

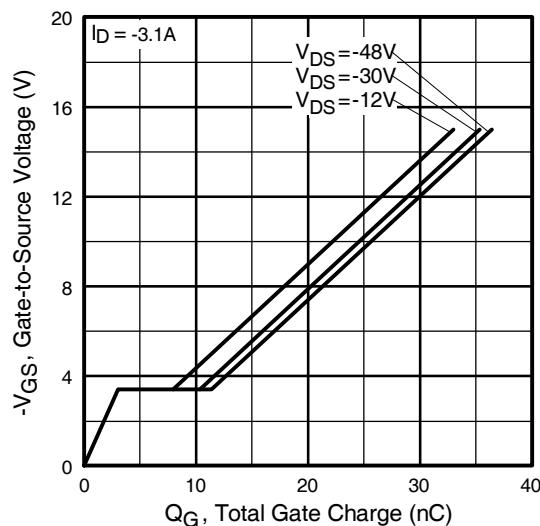


**Fig 19.** Maximum Avalanche Energy Vs. Drain Current

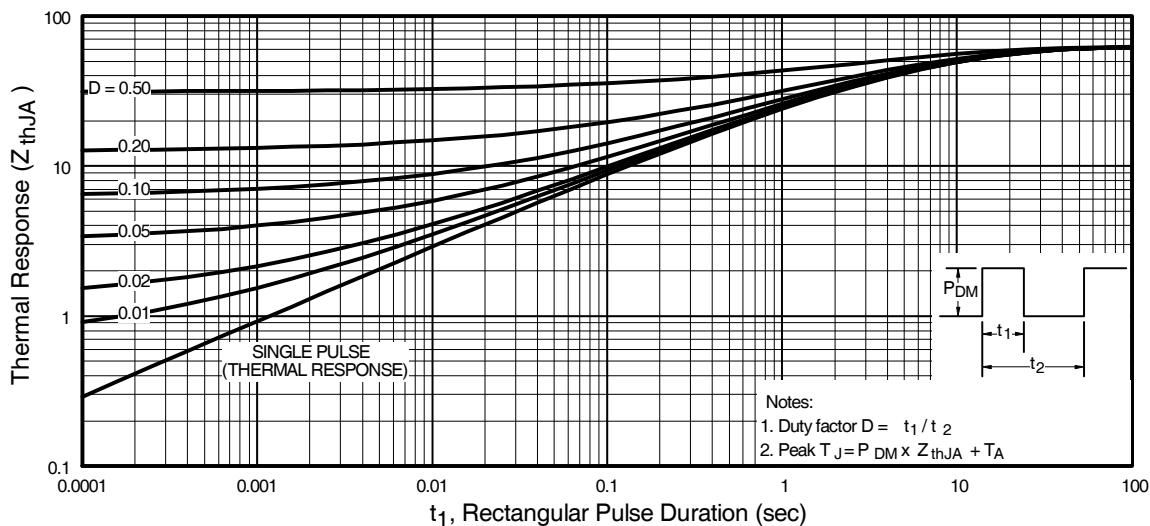
## P-Channel



**Fig 20.** Typical Capacitance Vs.  
Drain-to-Source Voltage



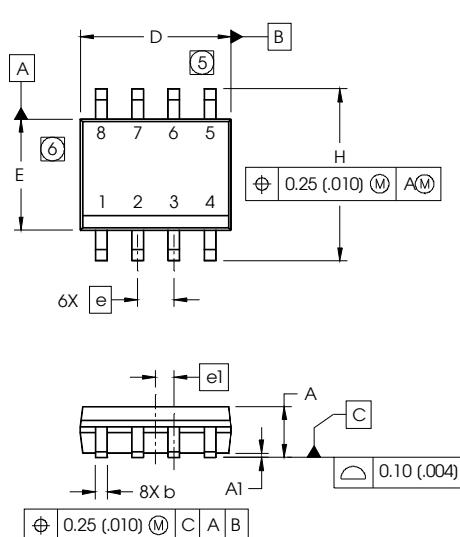
**Fig 21.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



**Fig 22.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

## **SO-8 Package Outline**

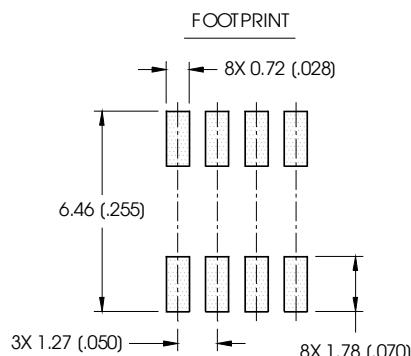
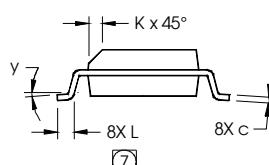
Dimensions are shown in millimeters (inches)



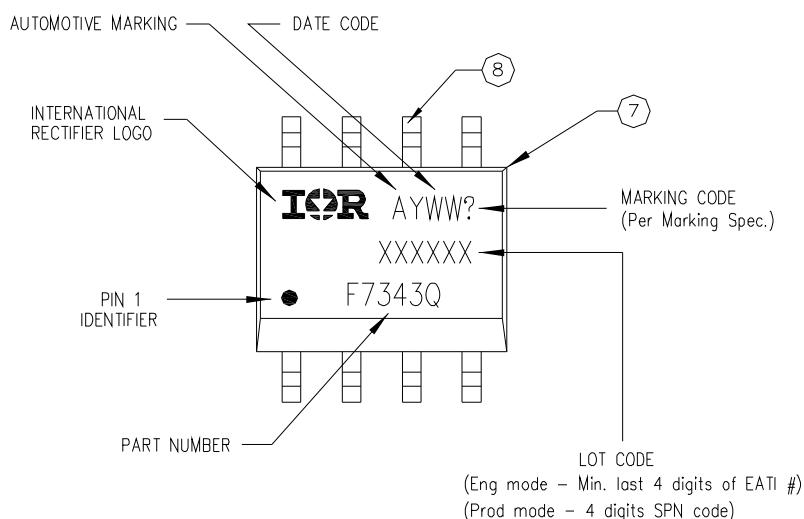
DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050 BASIC		1.27	BASIC
e1	.025 BASIC		0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°

**NOTES:**

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
  2. CONTROLLING DIMENSION: MILLIMETER
  3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
  4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA
  5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS.  
MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
  6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS.  
MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
  7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO  
A SUBSTRATE.



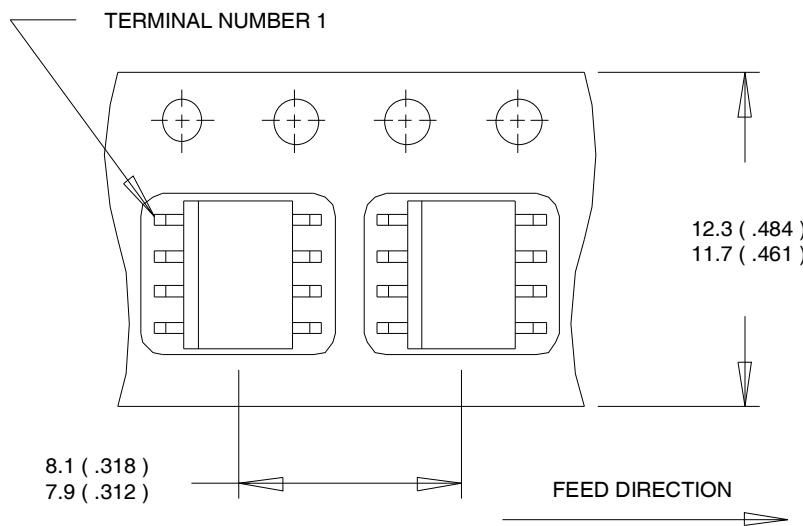
## SO-8 Part Marking



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

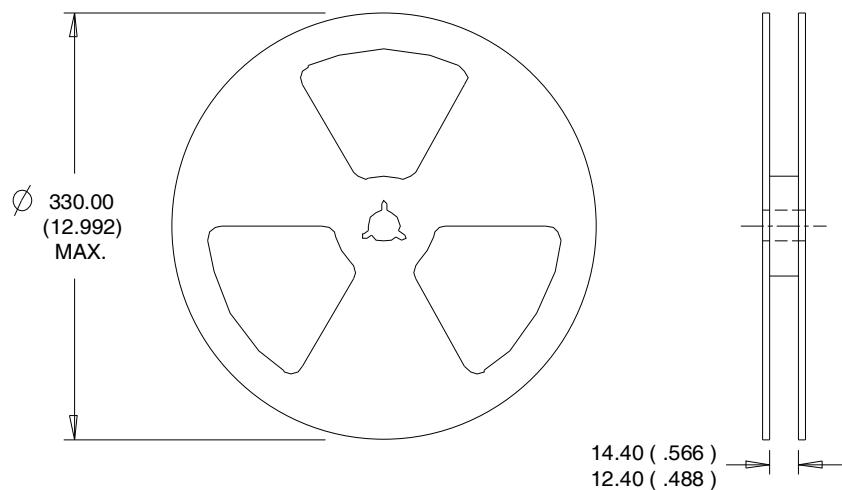
**SO-8 Tape and Reel**

Dimensions are shown in millimeters (inches)



## NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



## NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

<b>Qualification Level</b>		Automotive (per AEC-Q101) <sup>††</sup>	
Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
<b>Moisture Sensitivity Level</b>		SO-8	MSL1
<b>ESD</b>	Machine Model	Class M2 (200V) <sup>†††</sup> (per AEC-Q101-002)	
	Human Body Model	Class H1A (500V) <sup>†††</sup> (per AEC-Q101-001)	
	Charged Device Model	Class C5 (1125V) <sup>†††</sup> (per AEC-Q101-005)	
<b>RoHS Compliant</b>		Yes	

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/>

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage

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For technical support, please contact IR's Technical Assistance Center  
<http://www.irf.com/technical-info/>

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**Revision History**

Date	Comments
3/10/2014	<ul style="list-style-type: none"><li>• Added "Logic Level Gate Drive" bullet in the features section on page 1</li><li>• Updated data sheet with new IR corporate template</li></ul>